

SICE2003 Annual Conference Time Chart(1)					
	Room1(2-221M)	Room2(2-231M)	Room3(2-223L)	Room4(2-224M)	Room5(RB-L1)
8/4(Mon)	9:00-10:00 International Plenary Lecture I				
8/4(Mon)	[OS] Activities of Keiso (SICE Instrument and Control) Engineers (1) N. Aoshima/Univ. of Tsukuba	Image Recognition (1) S.Ishikawa/Kyushu I. of Tech. Dr.Z.Zhang/Industrial Technology Center of Okayama Pref.	Remote Sensing (1) K.Muramoto/Kanazawa Univ. L.Shiming/Northwestern Poly. Univ.	Analytical Measurement K.Kobayashi/Hosei Univ.	[OS] Recent Advances in Adaptive Control of Nonlinear Systems Shuzhi Sam GE/ The National Univ. of Singapore
10:20-12:00	J4	J4	J4	J2,E2	E4
Lunch					
8/4(Mon)	[OS] Activities of Keiso (SICE Instrument and Control) Engineers (2) N.Aoshima/Univ. of Tsukuba	Image Recognition (2) H.Maeda/Kyushu Inst. of Tech. M.Mikawa/Univ. of Tsukuba	Remote Sensing (2) Y.J.Oh/Kanagawa Univ.	Opt Electric Measurement (1) M.Baba/Okayama Univ.	[OS] Performance Limitations in Feedback Control Li Qiu/Hong Kong Univ. of Sci. & Tech. [Notice: 13:20-15:00]
13:20-14:40	J4	E4	J1,E2	J4	
8/4(Mon)	[OS] Recent Advances of Thermocouples in High Temperature Measurement F.Sakuma/AIST [Notice: 15:00-16:40]	Image Sensing A.Kobayashi/Tokyo Inst. of Tech. M.M.Rahman/Kyushu Inst. of Tech.	Sensors & Transducers (1) T.Furukawa/Saga Univ. T.Yamaguchi/Kumamoto Univ.	Opt Electronic Measurement (2) S. Shinohara/Shizuoka Univ.	E4 [OS] Hybrid Dynamical Systems I.Masubuchi/Hiroshima Univ. [Notice: 15:20-17:00]
15:00-16:20	J5	J3,E1	J1,E3	J1,E3	
8/4(Mon)		Applied Measurement Y.Tamura/Yamagata	Sensors & Transducers (2) K.Teramoto/Saga Univ. Y.H.Kim/Dong-A Univ.	Opt Electronic Measurement (3) A.Kimachi/Osaka Elect. Comm.	
16:40-18:00		J4	J5	J3	E5
8/5(Tue)	[OS] Inverse Problems in Measurement (1) S.Honda/Keio Univ.	Image Tracking K.Sato/Osaka Univ.	Signal Analysis (1) Y.Maeda/Kansai Univ. N.Tamaru/Otsu Women's Univ.	Thermometer (1) H.Sakurai/NMII/AIST	[OS] Time Delay and Predictive Control Systems (1) A.Kojima/Tokyo Metropolitan Inst. of Tech.
8:40-10:20	J5	J4	J3,E1	J5	E4
8/5(Tue)	[OS] Inverse Problems in Measurement (2) F.Kojima/Kobe Univ.	Image Inspection H.Kano/Tokyo Denki Univ.	Signal Analysis (2) K.Kubo/Oyama National Coll. of Tech.	Thermometer (2) M.Arai/AIST F.Sakuma/NMII/AIST	[OS] Time Delay and Predictive Control Systems (2) K.Watanabe/Yamagata Univ.
10:40-12:20	J4	J2,E4	J5	J5	E4
8/6(Wed)	[OS] Frontier of Mechanical Quantities Measurement (1) Y.Fujii/Gunma Univ.	Signal Processing (1) A.Sano/Keio Univ. C.Sumii/Sophia Univ.	Identification (1) H.Harada/Kumamoto Univ.	Temperature Measurement (1) I.Kishimoto/AIST	[OS] From Model Based Control to Dynamics Based Control (1) F.Matsuno/Univ. of Electro-Comm.
8:40-10:20	J4	E4	J1,E4	J4,E1	E3
8/6(Wed)	[OS] Frontier of Mechanical Quantities Measurement (2) Y.Yoshimura/ Tokyo National College of Tech.	Signal Processing (2) K.Matsuoka/Kyushu Inst. of Tech. S.Nakamori/Kagoshima Univ.	Identification (2) T.Furuya/Kitakyushu Coll. of Tech. Y.Sawada/Kyoto Inst. of Tech.	Temperature Measurement (2) Y.Tamura/Nagasaki Inst. of Applied Science T.Taira/Inst. for Molecular Sci.	[OS] From Model Based Control to Dynamics Based Control (2) K.Fujimoto/Kyoto Univ.
10:40-12:20	J4	J1,E5	J4	J5	J1,E2
Lunch					
8/6(Wed)	[OS] Frontier of Mechanical Quantities Measurement (3) S.Kurosu/ Oyama National Coll. of Tech.	Applied Signal Processing S.Tanaka/Yamaguchi Univ.	Image Processing K.Deguchi/Tohoku Univ. K.Kamejima/Osaka Inst. of Tech.	Standard of Measurement M.Okugawa/Gifu National Coll.	[OS] Bio-Mimetic Control Application M.Yamakita/Tokyo Inst. of Tech.
13:20-15:00	J4	E4	E5	J5	J3,E2
8/6(Wed)	15:20-16:20 International Plenary Lecture II 16:30-17:30 Closing Session and Farewell Party				

(Note)Presentation;
J:Japanese,E:English

The above Chair Candidate is subject to change